

Search Notes

Application/Control No.

10/688,429

Examiner

Feben M. Haile

Applicant(s)/Patent under
Reexamination

HEFTY ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	231	4/30/2007	FH
370	236	4/30/2007	FH
370	395.71	4/30/2007	FH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search: buffer, queue, storage, memory, credit,	4/30/2007	FH